

**Notice of References Cited**

Application/Control No.

10/044,522

Applicant(s)/Patent Under

Reexamination

TONCICH, STAN

Examiner

Justin P. Bettendorf

Art Unit

2817

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,965,494	10-1999	Terashima et al.	505/210
	B	US-3,569,795	03-1971	Gikow, Emanuel	361/434
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05182857 A	07-1993	Japan	HOSHIBA, KAZUHIRO	H01G 04/06
	O	JP 63128618 A	06-1988	Japan		H01G 07/06
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.